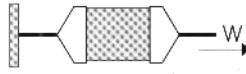
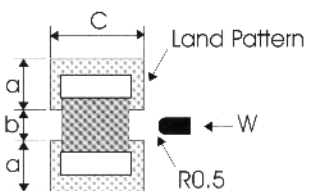
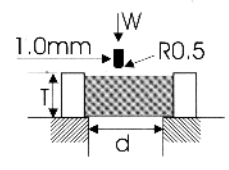


## ■ Reliability & Test Conditions

Items	Requirements			Test Conditions	
	0402	0603	0805		
Operating temp. range	-55℃ ~ +125℃				
Storage temp. range	40℃ max., 70% RH max.			at packing condition	
Resistance to solder heat	1. No damage such as cracks should be caused in chip element. 2. More than 75% of the terminal electrode shall be covered with new solder.			* Preheat Temperature : 100 ~ 150℃ * Preheat Time : 1 min. * Solder Temperature : 260 ± 10℃ * Dipping Time : 10 ± 0.5 Sec.	
Solderability	1. More than 90% of the terminal electrode shall be covered with new solder.			* Preheat Temperature : 100 ~ 150℃ * Preheat Time : 1 min. * Solder Temperature : 230 ± 10℃ * Dipping Time : 3 ± 1 Sec.	
Reflow soldering	1. More than 50% of the terminal electrode shall be covered with new solder. 2. Varistor voltage change : Within ±10%			* Preheat Temperature : 150℃ * Preheat Time : 1 min. * Solder Temperature : 230℃ * Solder Time : 10 Sec. max.	
Tensile strength (Terminal strength)	1. No mechanical damage			 W(kgf) min	
	W	-	1.0		2.0
Flexure strength	1. No mechanical damage				
	unit : mm, kgf				
	a	-	1.0		1.0
	b	-	0.8		1.0
	c	-	1.3		1.3
W	-	1.0	4.0		

## ■ Reliability & Test Conditions

Items	Requirements			Test Conditions
	0402	0603	0805	
Bending strength	1. The body shall not be damaged by forces applied on the fight.			
	unit : mm (d), kgf (w)			
	d	-	1.3	
	W	-	2.0	3.0
Drop	1. No mechanical damage			* Drop 10 times on a concrete floor from a height of 91cm.
Vibration	1. No mechanical damage			* Frequency : 10-55-10HZ * Amplitude : 1.52mm * Direction and time : x, y and z directions for 1 hour
Thermal shock ( temperature cycle )	1. No mechanical damage 2. Varistor voltage change : Within $\pm 10\%$			* Temperature : $-40\pm 3^{\circ}\text{C}$ , $+85\pm 3^{\circ}\text{C}$ * Cycle : $30\pm 3\text{min}$ , each 100 cycles then measured at room ambient temperature after placing for 24 hours
Heat load resistance				* Temperature : $85\pm 2^{\circ}\text{C}$ * Applied voltage : DC bias voltage * Time : 1000 hours * Measured at room ambient temperature after placing for 24 hours
Low temperature resistance				* Temperature : $-40\pm 5^{\circ}\text{C}$ * Time : 1000 hours * Measured at room ambient temperature after placing for 24 hours
Humidity resistance				* Temperature : $40\pm 2^{\circ}\text{C}$ * Humidity : 90 ~ 95% RH * Time : 500 hours * Measured at room ambient temperature after placing for 24 hours
Humidity load resistance				* Temperature : $40\pm 2^{\circ}\text{C}$ * Humidity : 90 ~ 95% RH * Applied voltage : DC bias voltage * Time : 500 hours * Measured at room ambient temperature after placing for 24 hours

## ■ Reliability & Test Conditions

Items	Requirements			Test Conditions
	0402	0603	0805	
Maximum surge current	1. Varistor voltage change : Within $\pm 10\%$  IEC1000-4-5 standard 1.2/50 $\mu\text{s}$ - 8/20 $\mu\text{s}$ voltage - current combination pulse			* Temperature : $25 \pm 5^\circ\text{C}$ * Humidity : 30~65% RH * Polarity : +, - * Number of hit : each 1 time * Surge pulse : 8/20 $\mu\text{s}$ pulse * Applied current : maximum surge current(Is)
Maximum surge energy	1. Varistor voltage change : Within $\pm 10\%$  IEC1000-4-5 standard 10/1000 $\mu\text{s}$ current pulse			* Temperature : $25 \pm 5^\circ\text{C}$ * Humidity : 30~65% RH * Number of hit : 1 time * Surge pulse : 10/1000 $\mu\text{s}$ pulse * Applied energy : maximum surge energy(Ws)
ESD life	1. No mechanical damage 2. Varistor voltage change : Within $\pm 10\%$ ESD gun (IEC1000-4-2 standard) C=150pF R=330 $\Omega$			* Discharge : Contact discharge * Voltage : 8,000V (level 4) * Polarity : +, - * Number : 10,000 times in 10 sec.
ESD test	1. No mechanical damage 2. Varistor voltage change : Within $\pm 10\%$ ESD gun (IEC1000-4-2 standard) C=150pF R=330 $\Omega$			* Discharge : Air discharge * Voltage : 25,000V (Special level) * Polarity : +, - * Number : 10 times in 10 sec.